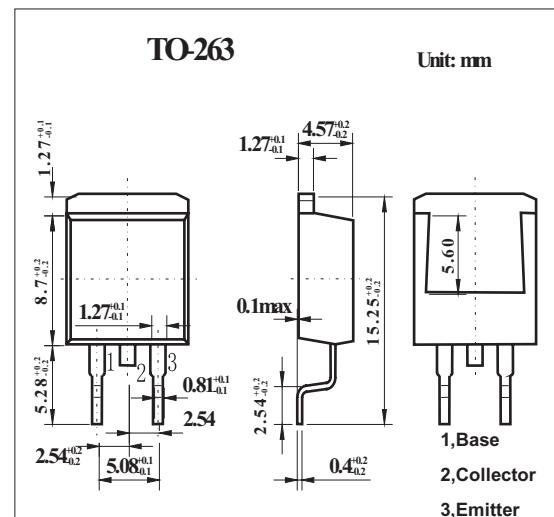


NPN Triple Diffused Planar Silicon Transistor**2SC4602****■ Features**

- Surface mount type device making the following possible.
- Reduction in the number of manufacturing processes for 2SC4602-applied equipment.
- High density surface mount applications.
- Small size of 2SC4602-applied equipment.
- High breakdown voltage, high reliability.
- Fast switching speed.
- Wide ASO.
- Adoption of MBIT process.

**■ Absolute Maximum Ratings Ta = 25°C**

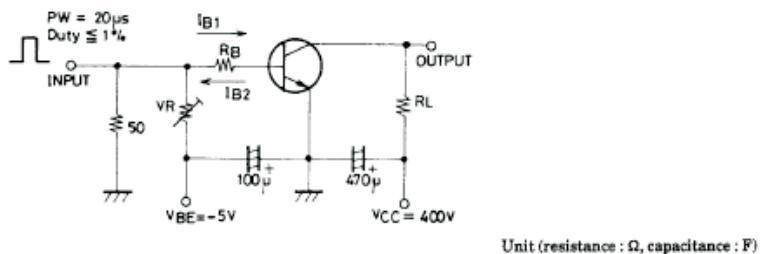
Parameter	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	1100	V
Collector-emitter voltage	V _{CEO}	800	V
Emitter-base voltage	V _{EBO}	7	V
Collector current (DC)	I _C	3	A
Collector current (Pulse) *	I _{CP}	10	
Base current	I _B	1.5	A
Collector power dissipation Ta = 25°C Tc = 25°C	P _C	1.65 50	W
Junction temperature	T _j	150	°C
Storage temperature range	T _{stg}	-55 to +150	°C

* PW≤300ms, duty cycle≤10%

2SC4602■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Collector cut-off current	I_{CBO}	$V_{CB} = 800 \text{ V}, I_E = 0$			10	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = 5 \text{ V}, I_C = 0$			10	μA
DC current gain	h_{FE}	$V_{CE} = 5 \text{ V}, I_C = 0.2\text{A}$	10		40	
		$V_{CE} = 5 \text{ V}, I_C = 1\text{A}$	8			
Gain-Bandwidth product	f_T	$V_{CE} = 10 \text{ V}, I_C = 0.2\text{A}$		15		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, f=1\text{MHz}$		60		pF
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$	$I_C = 1.5 \text{ A}, I_B = 0.3\text{A}$			2.0	V
Base-emitter saturation voltage	$V_{BE(\text{sat})}$	$I_C = 1.5 \text{ A}, I_B = 0.3 \text{ A}$			1.5	V
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C = 1 \text{ mA}, I_E = 0$	1100			V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C = 5 \text{ mA}, R_{BE}=\infty$	800			V
Emitter-to-Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E=1\text{mA}, I_C=0$	7			V
Collector-to-Emitter Sustain Voltage	$V_{CEO(\text{SUS})}$	$I_C=1.5\text{A}, I_{B1}=-I_{B2}=0.3\text{A}, L=2\text{mH}$	800			V
Turn-ON time	t_{on}	$I_C=2\text{A}, I_{B1}=0.4\text{A}, I_{B2}=-0.8\text{A}, R_L=200\Omega, V_{CC}=400\text{V}$			0.5	μs
Storage time	t_{stg}				3.0	
Fall time	t_f				0.3	

■ Switching Time Test Circuit



■ hFE Classification

Rank	K	L	M
hFE	10 to 20	15 to 30	20 to 40